Notice of References Cited

Application/Control No.

10/747,873

Applicant(s)/Patent Under Reexamination
BENEDETTI, MICHELE

Examiner

Daniel I. Walsh

Art Unit
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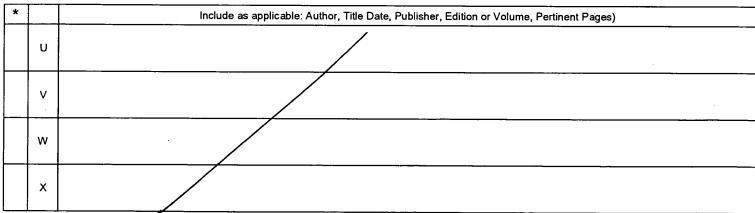
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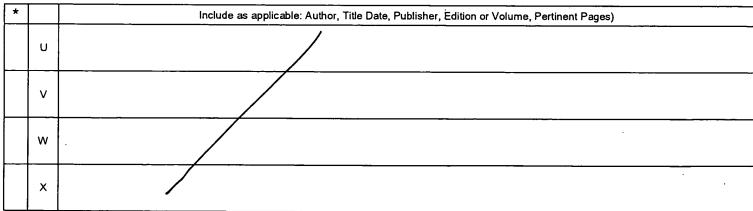
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